

#### SW4N70K2-VB TO251 Datasheet

N-Channel 700V (D-S) Super Junction Power MOSFET

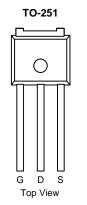
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	700			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 1.1			
Q <sub>g</sub> (Max.) (nC)	15			
Q <sub>gs</sub> (nC)	3			
Q <sub>gd</sub> (nC)	6			
Configuration	Single			

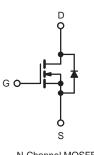
#### **FEATURES**

- Low Gate Charge  $\mathbf{Q}_{g}$  Results in Simple Drive Requirement



- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC





N-Channel	MOSFET
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ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, u	nless otherw	vise noted				
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V <sub>DS</sub>	700	V		
Gate-Source Voltage			V <sub>GS</sub>	± 30	V		
Continuous Drain Current <sup>e</sup>	$\lambda$ of 10 $\lambda$	T <sub>C</sub> = 25 °C	1	5			
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 100 ^{\circ}C$		ID	4	А		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	16			
Linear Derating Factor				1.67/0.8/0.3	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	120	mJ		
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	34	А		
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	17	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		T <sub>C</sub> = 25 °C		PD	205/35/30	W
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns		
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	- °C		
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s			300			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
Mounting Torque				1.1	N · m		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T<sub>J</sub> = 25 °C, L = 24 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AS</sub> = 3.2 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  3.2 A, dl/dt  $\leq$  90 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



PARAMETER	SYMBOL	TYP	·.	MAX.			UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62		°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	- 3.6/1.2/0.6		6			
<b>SPECIFICATIONS</b> $T_J = 25 \ ^{\circ}C$ ,	unless other	wise noted						
PARAMETER	SYMBOL	TES	ST CONDITION	IS	MIN.	TYP.	MAX.	UNIT
Static								•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250	μA	700	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> :	= 1 mA <sup>d</sup>	-	0.6	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250	μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 30 V$		-	-	± 100	nA
Zero Gate Voltage Drain Current	lann	V <sub>DS</sub> =	= 700 V, V <sub>GS</sub> =	0 V	-	-	10	
Zero Gale Voltage Drain Gurrent	IDSS	V <sub>DS</sub> = 520 V	20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		I	-	100	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 2	2.5 A <sup>b</sup>	-	1.1	-	Ω
Forward Transconductance	<b>g</b> <sub>fs</sub>	$V_{DS} = 50 \text{ V}, \text{ I}_{D} = 2.5 \text{ A}$		8	-	-	S	
Dynamic								
Input Capacitance	Ciss	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1 0 M H = 200 fr = 5		-	320	-		
Output Capacitance	C <sub>oss</sub>			-	75	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	T = 1	f = 1.0 MHz, see fig. 5		-	4	-	pF
Output Capacitance	6	$C_{oss} \qquad \qquad V_{GS} = 0 \text{ V} \qquad \qquad V_{DS} = 1.0 \text{ V}, \text{ f} = 1.0 \text{ MHz}$ $V_{GS} = 520 \text{ V}, \text{ f} = 1.0 \text{ MHz}$	V <sub>DS</sub> = 1.0 V	f = 1.0 MHz	-	500	-	μг
	U <sub>OSS</sub>		, f = 1.0 MHz	-	83	-		
Effective Output Capacitance	Coss eff.		$V_{DS} = 0 V \text{ to } 520 V^{c}$		-	14	-	
Total Gate Charge	Qg		I <sub>D</sub> = 2.5 A, V <sub>DS</sub> = 400 V see fig. 6 and 13 <sup>b</sup>		-	-	15	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V			-	-	3	
Gate-Drain Charge	Q <sub>gd</sub>		see fig. 6	S and 13 <sup>b</sup>	-	-	6	1
Turn-On Delay Time	t <sub>d(on)</sub>				-	18	-	
Rise Time	t <sub>r</sub>		= 325 V, I <sub>D</sub> = 3		-	40	-	1
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_{G} = 9.1 \Omega, R_{D} = 62 \Omega,$ see fig. 10 <sup>b</sup>		-	50	-	- ns	
Fall Time	t <sub>f</sub>			-	30	-		
Drain-Source Body Diode Characteristic	s	-				-		
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	5	- A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	p - n junction diode			I	-	16	
Body Diode Voltage	V <sub>SD</sub>	$T_J$ = 25 °C, I <sub>S</sub> = 3.2 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$- T_{J} = 25 \text{ °C}, I_{F} = 3.2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	180	-	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	2.1	3.2	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	urn-on time is r	negligible (turn	on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

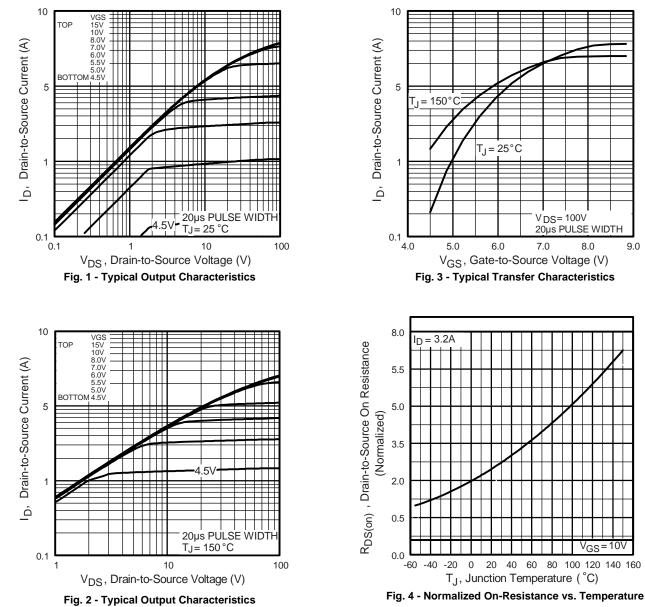
b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

d. t = 60 s, f = 60 Hz.



9.0



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



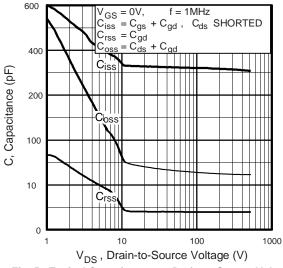


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

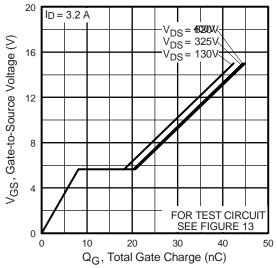


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

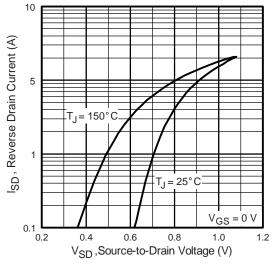
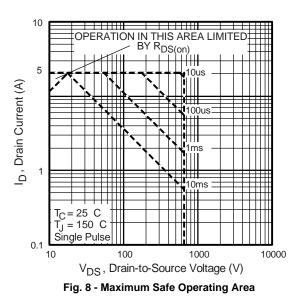


Fig. 7 - Typical Source-Drain Diode Forward Voltage





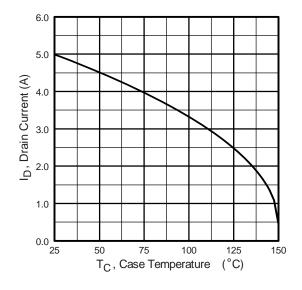


Fig. 9 - Maximum Drain Current vs. Case Temperature

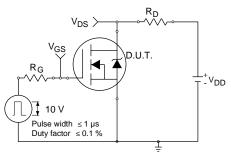


Fig. 10a - Switching Time Test Circuit

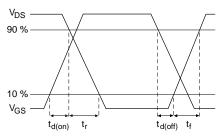
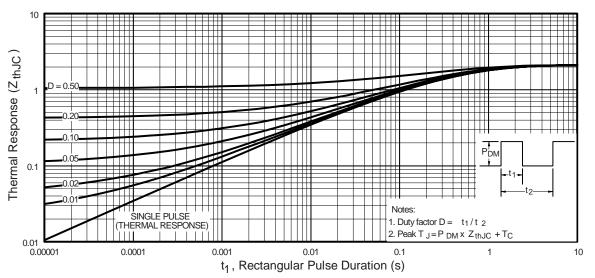
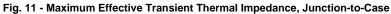


Fig. 10b - Switching Time Waveforms





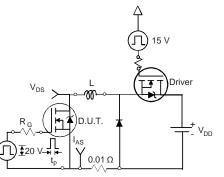


Fig. 12a - Unclamped Inductive Test Circuit

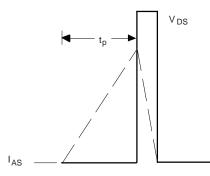


Fig. 12b - Unclamped Inductive Waveforms



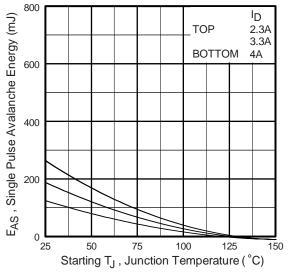


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

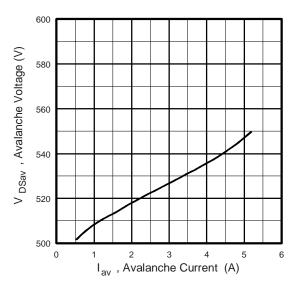


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

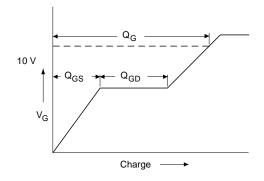


Fig. 13a - Basic Gate Charge Waveform

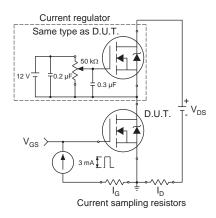
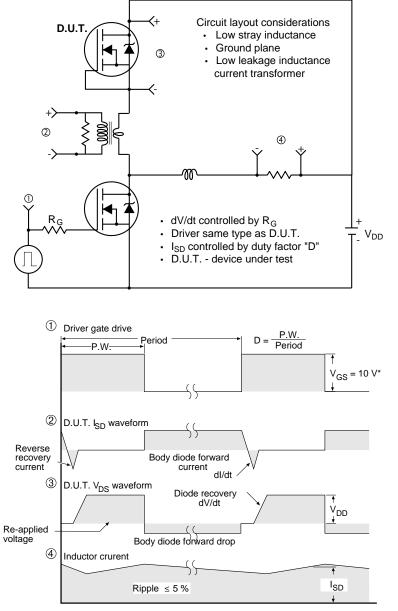


Fig. 13b - Gate Charge Test Circuit





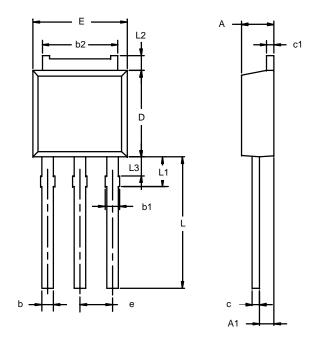
Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel



#### TO-251AA (DPAK)



	MILLIMETERS		INC	HES		
Dim	Min	Max	Min	Max		
Α	2.21	2.38	0.087	0.094		
A1	0.89	1.14	0.035	0.045		
b	0.71	0.89	0.028	0.035		
b1	0.76	1.14	0.030	0.045		
b2	5.23	5.43	0.206	0.214		
С	0.46	0.58	0.018	0.023		
c1	0.46	0.58	0.018	0.023		
D	5.97	6.22	0.235	0.245		
Е	6.48	6.73	0.255	0.265		
е	2.28	2.28 BSC		0.090 BSC		
L	8.89	9.53	0.350	0.375		
L1	1.91	2.28	0.075	0.090		
L2	0.89	1.27	0.035	0.050		
L3	1.15	1.52	0.045	0.060		
ECN: S-0 DWG: 53	3946—Rev. I 46	E, 09-Jul-01				

Note: Dimension L3 is for reference only.



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